

RF POWER MOSFETs

N-CHANNEL ENHANCEMENT MODE

200V 300W 45MHz

The ARF466A and ARF466B comprise a symmetric pair of common source RF power transistors designed for push-pull scientific, commercial, medical and industrial RF power amplifier applications up to 45 MHz. They have been optimized for both linear and high efficiency classes of operation.

- Specified 150 Volt, 40.68 MHz Characteristics:

Output Power = 300 Watts.

Gain = 16dB (Class AB)

Efficiency = 75% (Class C)

- Low Cost Common Source RF Package.

- Low V_{th} thermal coefficient.

- Low Thermal Resistance.

- Optimized SOA for Superior Ruggedness.

MAXIMUM RATINGS

All Ratings: T_C = 25°C unless otherwise specified.

Symbol	Parameter	ARF466A_B(G)	UNIT
V _{DSS}	Drain-Source Voltage	1000	Volts
V _{DGO}	Drain-Gate Voltage	1000	
I _D	Continuous Drain Current @ T _C = 25°C	13	Amps
V _{GS}	Gate-Source Voltage	±30	Volts
P _D	Total Power Dissipation @ T _C = 25°C	357	Watts
R _{θJC}	Junction to Case	0.35	°C/W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to 150	°C
T _L	Lead Temperature: 0.063" from Case for 10 Sec.	300	

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
BV _{DSS}	Drain-Source Breakdown Voltage (V _{GS} = 0V, I _D = 250 μA)	1000			Volts
R _{DS(ON)}	Drain-Source On-State Resistance (V _{GS} = 10V, I _D = 6.5A)			1.0	ohms
I _{DSS}	Zero Gate Voltage Drain Current (V _{DS} = 1000V, V _{GS} = 0V)			25	μA
	Zero Gate Voltage Drain Current (V _{DS} = 800V, V _{GS} = 0V, T _C = 125°C)			250	
I _{GSS}	Gate-Source Leakage Current (V _{GS} = ±30V, V _{DS} = 0V)			±100	nA
g _{fs}	Forward Transconductance (V _{DS} = 25V, I _D = 6.5A)	3.3	7	9	mhos
V _{GS(TH)}	Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 1mA)	2		4	Volts

 CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

DYNAMIC CHARACTERISTICS

ARF466A_B(G)

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C_{iss}	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 150V$ $f = 1\text{ MHz}$		2000		pF
C_{oss}	Output Capacitance			165		
C_{rss}	Reverse Transfer Capacitance			75		
$t_{d(on)}$	Turn-on Delay Time	$V_{GS} = 15V$ $V_{DD} = 500\text{ V}$ $I_D = 13A @ 25^\circ C$ $R_G = 1.6W$		12		ns
t_r	Rise Time			10		
$t_{d(off)}$	Turn-off Delay Time			43		
t_f	Fall Time			10		

FUNCTIONAL CHARACTERISTICS

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
G_{PS}	Common Source Amplifier Power Gain	$f = 40.68\text{ MHz}$	14	16		dB
η	Drain Efficiency	$V_{GS} = 2.5V$ $V_{DD} = 150V$	70	75		%
Ψ	Electrical Ruggedness VSWR 10:1	$P_{out} = 300W$	No Degradation in Output Power			

① Pulse Test: Pulse width < 380μS, Duty Cycle < 2%

APT Reserves the right to change, without notice, the specifications and information contained herein.

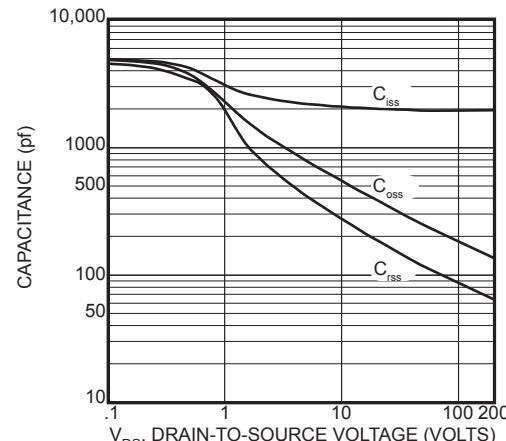


Figure 2, Typical Capacitance vs. Drain-to-Source Voltage

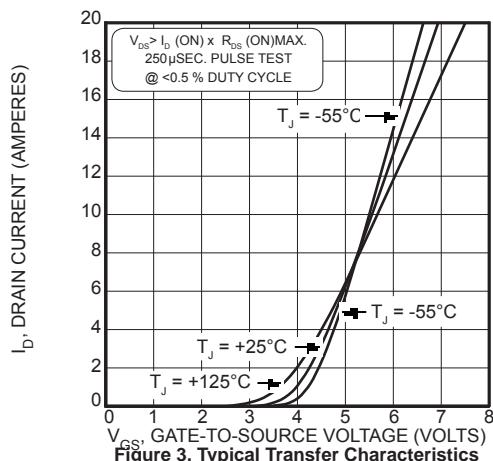


Figure 3, Typical Transfer Characteristics

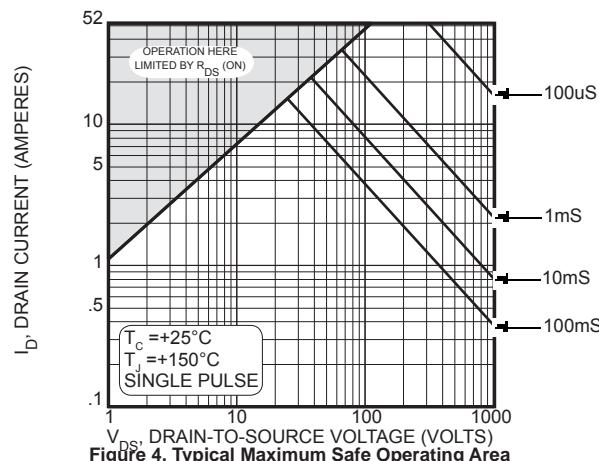
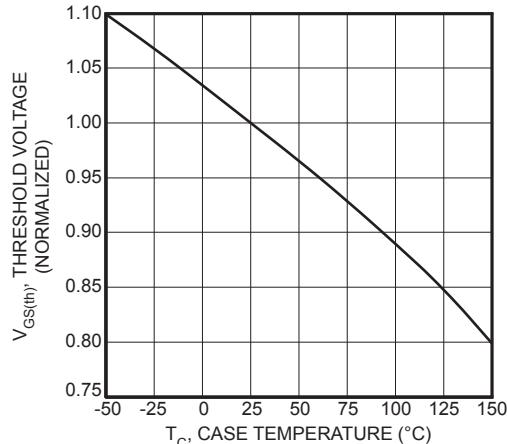


Figure 4, Typical Maximum Safe Operating Area

TYPICAL PERFORMANCE CURVES



ARF466A_B(G)

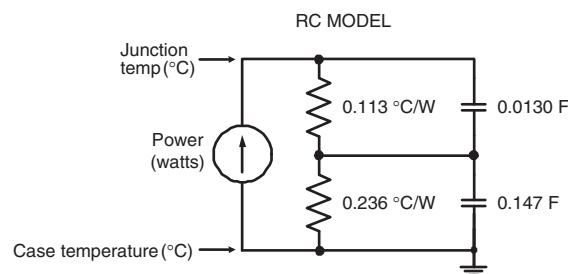
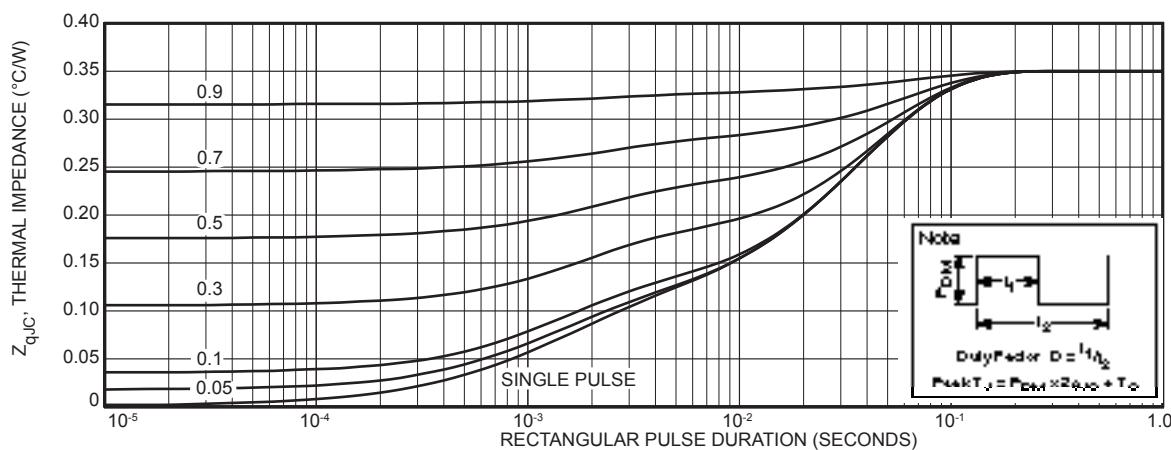
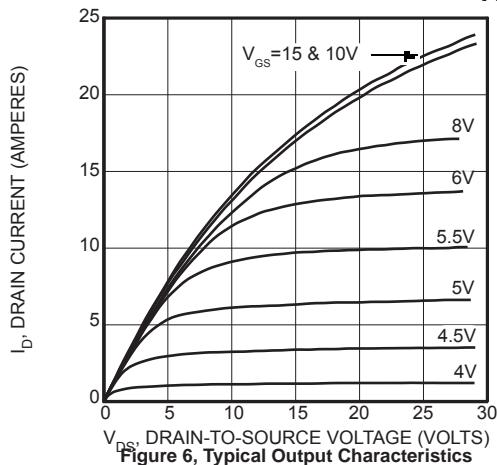


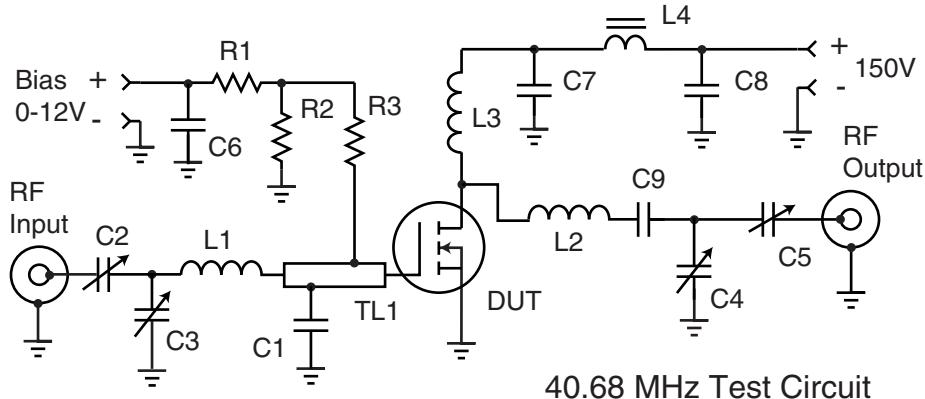
Figure 7b, TRANSIENT THERMAL IMPEDANCE

Table 1 - Typical Class AB Large Signal Input - Output Impedance

Freq. (MHz)	Z _{IN} (Ω)	Z _{OL} (Ω)
2.0	17.9 - j 11.2	30 - j 1.7
13.5	1.1 - j 4.9	25.7 - j 9.8
27.1	.25 - j 1.5	18 - j 13.3
40.7	.15 - j 0.9	12 - j 12.6
65	.31 + j 2.0	6.2 - j 8.9

Z_{IN} - Gate shunted with 25Ω

Z_{OL} - Conjugate of optimum load for 300W output at V_{dd} = 150V



C1 -- 2200 pF ATC 700B

C2-C5 -- Arco 465 Mica trimmer

C6-C8 -- .1 μ F 500V ceramic chip COG

C9 -- 3x 2200 pF 500V chips COG

L1 -- 4t #22 AWG .25"ID .25 "L ~87nH

L2 -- 5t #16 AWG .312" ID .35" L ~176nH

L3 -- 10t #24 AWG .25"ID ~.5 μ HL4 -- VK200-4B ferrite choke 3 μ HR1- R3 -- 1k W 0.5 Ω CarbonTL1 -- 38 Ω t-line .175 x 1 in long

C1 .45" from gate pin.

DUT = ARF466A/B

TO-264 (L) Package Outline